



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

U.S. Application of:

Teruo FUJII, Yasuhiro SANDO, Yasuhisa FUJII and

Kusunoki HIGASHINO

For:

MICROFLUIDIC DEVICE

Confirmation No.:

4519

U.S. Serial No.:

10/664,436

Filed:

September 17, 2003

Group Art Unit:

To Be Assigned

Examiner:

To Be Assigned

Commissioner for Patents

P. O. Box 1450

Alexandria, VA 22313-1450

Dear Sir:

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P. O. Box 1450, Alexandria, VA 22313-1450, on

June 4, 2004

Date of Deposit

Tung T. Nguyen

Name of Applicant, Assignee, or Registered Representative

June 4, 2004

Date of Signature

June 4, 2004

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. §1.97(e)

In compliance with the duty of disclosure set forth in 37 C.F.R. § 1.56, Applicants wish to bring the following items to the attention of the Examiner. A copy of each of the items is enclosed for the convenience of the Examiner.

No representation is made, and no representation is intended, that more relevant material does not exist, or that the order of presentation of this material in any way reflects its relative pertinence. Specifically, this presentation is not an admission that the items listed below are properly citable against the above-identified application.

Serial No.: 10/664,436

Submitted herewith is a copy of a European Search Report, dated March 9, 2004, for counterpart European Patent Application No. EP 03 02 0594. The European Search Report cites the following references in the order listed below:

- (1) Bustgens et al, U.S. Patent No. 5,725,363, issued March 10, 1998;
- (2) International Published Application No. (A2) WO 02/053290 (PRESIDENT AND FELLOWS OF HARVARD COLLEGE), published July 11, 2002;
- (3) European Published Application No. (A2) 0 568 902 (WESTONBRIDGE INTERNATIONAL LIMITED), published November 10, 1993; and
- (4) S. R. Quake et al, "From Micro- to Nanofabrication With Soft Materials", Issues in Nanotechnology Review, SCIENCE, November 24, 2000, Vol 290, pp. 1536-1540.

In accordance with 37 CFR § 1.97(e), it is hereby certified that each item of information contained in this Supplemental Information Disclosure Statement is being filed within three months of being first cited in a foreign communication in a counterpart foreign application and additionally, as a first office action on the merits has not been received, no fee is incurred. If it should be determined that a fee is required, please charge any required fee (other than the issue fee) during the pendency of this application to Sidley Austin Brown & Wood LLP's Deposit Account No. 18-1260.

Respectfully submitted,

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			Jul. 2002		WIPO			165	NO	
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)										
_	"From Micro-to Nanofabrication with Soft Materials" SCIENCE vol. 290, 24 November, 2000 by Stephen R. Quake and Axel Scherer, pp. 1536-1540									
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with next communication to applicant.